

**ABSTRACT**

【SUMMARY】

【OBJECT】

To provide an object lens and a condenser that  
5 allow an observation to be performed more  
microscopically than dark field observation.

【MEANS FOR SOLVING】

A plurality of shield plates 8 are rotatably  
disposed at a fit portion 3a of an object lens 100 in  
10 the vertical direction of an optical axis so that the  
shield plates 5 can be opened/closed. Thus, dark field  
illumination light that passes through an optical path  
5 can be shielded. In addition, the incident area and  
incident direction of the dark field illumination light  
15 to a ring-shaped lens 6 that emits the dark field  
illumination light to an object can be varied. As a  
result, microscopic flaws, unevenness, and foreign  
matter that cannot be detected by the conventional dark  
field observation can be observed and directional flaws  
20 can be observed.

【SELECTED DRAWING】 Fig. 2